

# Electronics Design & Manufacturing Activities

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Center Electronics Design & Manufacturing



# Electronics Design & Manufacturing



Imec's Center EDM team  
>70 years industry  
>20 years research  
experience in electronics

***We bridge the gap  
between research  
and industry***



**Better electronics  
at  
reduced cost  
through  
science based  
design & production  
methods**

1. Research and Development
2. Guidelines
3. Industry support

# 1. R&D activities

*EDM wants to provide science based answers to long standing questions in PCB/PBA design and manufacturing.*

General question:

Take PCB/PBA design option N

N: component type, PCB material, component placement, test access,...

The buy-in cost of option N is clear but what about:

- PCB Manufacturability and PCB cost?
- PBA Manufacturability and assembly cost?
- Quality and non-quality cost?
- Reliability, field-repair cost and lost reputation?

The answer requires the quantification of less tangible properties like manufacturability, quality and reliability.

# 1. R&D activities

## Quantified Quality:

- The **Quantified Quality  $Q$**  of a part/product is the probability of having **no defect**.
- A **defect** is any property that does not meet expectations.

## Properties:

- $Q = \text{Yield (first pass - after test)}$
- $\text{Zero Hour Defect Rate} = 1 - Q$  ( $Q$ : as delivered quality)
- $Q$  decreases with increasing number of Defect Opportunities (complexity) and manufacturing processes.
- $Q$  improves by introducing test and repair.

Note: *In real life there is no such thing as "Zero Defect Manufacturing"*

# 1. R&D activities

## Quantified Quality:

- Started with IPC-7912 on PBA
- Expanded to complete mechatronic systems in MoVIP: *Modellering van de Voorspelbaarheid van Initiële Productkwaliteit*. (Point One project)

Added value of Quantified Quality concept:

- **Quality** becomes measurable and quantifiable. One can assign **an objective value** to it.
- **Test** - perceived as an overhead cost - transforms into an quality improving therefore **a value adding process**.
- Predictability of quality. Base for **Design-for-Quality**.
- Base for **a common quantified quality language** in the supply chain.

# 1. R&D activities

## R&D behind Quantified Quality

- Development of quantification concept
  - PBA: Based on IPC-7912 defect opportunity  
*component-placement-interconnection defects*
  - Mechatronic systems:  
*Parts – Virtual Connector Parts (connections)*
- Manufacturability modeling
- Failure probability models
- Test coverage models
- Tool

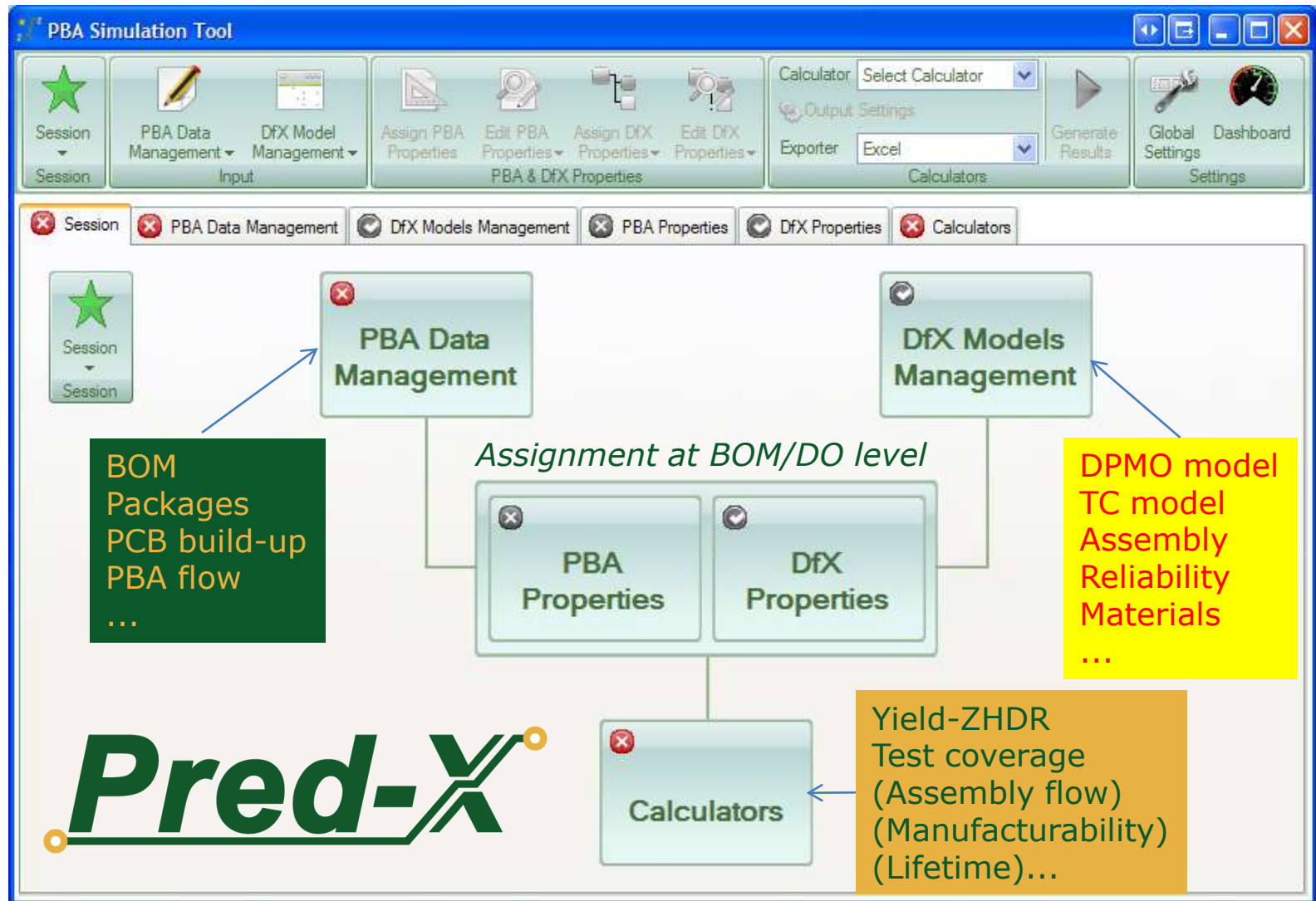
# 1. R&D Activities

## *Pred-X*

- Generic DfX supporting tool
- Can be used very early in design phase (concept phase)
- Quantified prediction of PBA DfX properties
- V1.0: Yield and test coverage prediction (2013)



# 1. R&D Activities



# 1. R&D Activities

## **Manufacturability**

- Compatibility of BOM including passives with lead-free solder profiles.
- BOM based estimation of on-board temperature differences during reflow soldering.
- BOM based assembly flow & process time prediction
- PCB manufacturing flow & process time prediction
- Sense or Nonsense of thermal reliefs
- ...

# 1. R&D Activities

## Thermal relief

## AC Impedance

$h=0,2\text{mm}$	$h=0,6\text{mm}$	$h=1\text{mm}$
61pH	76pH	74pH

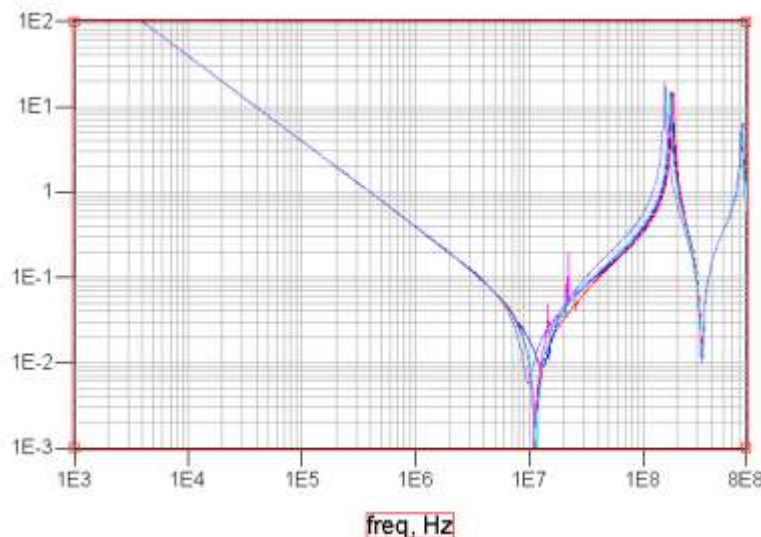
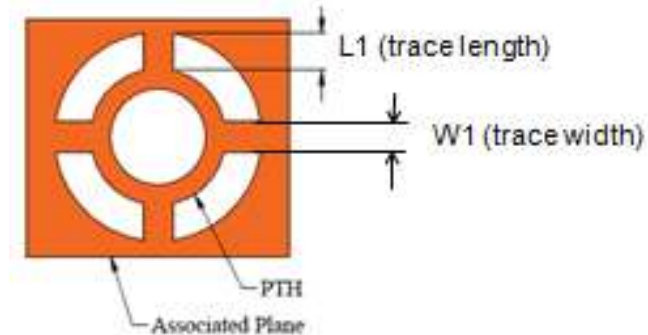
$l=0,25\text{mm}$	$l=0,5\text{mm}$
61pH	101pH

1 leg	2 legs	3 legs	4 legs
439pH	185pH	104pH	61pH

$w=100\mu\text{m}$	$w=200\mu\text{m}$	$w=300\mu\text{m}$
61pH	41pH	26pH

$D=0,35\text{mm}$	$D=0,5\text{mm}$	$D=0,65\text{mm}$
61pH	72pH	77pH

Thermal relief with decoupling caps



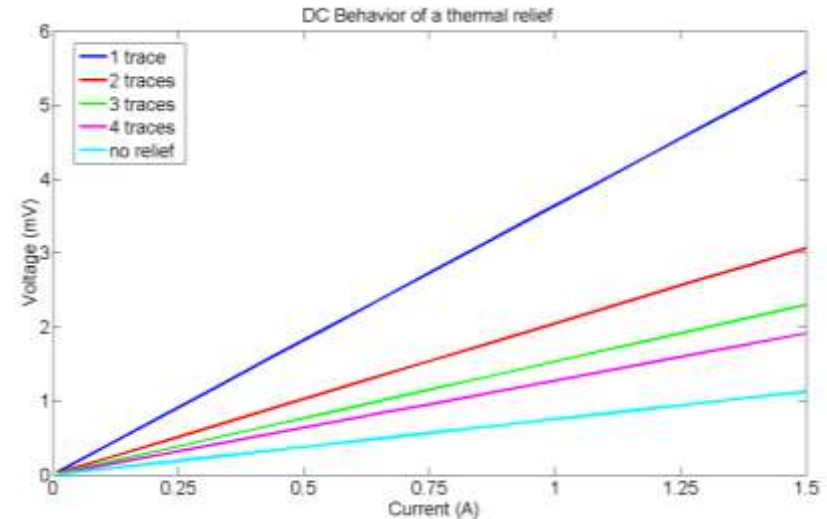
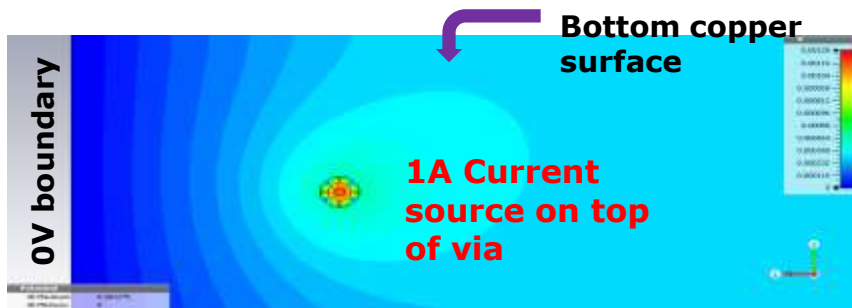
At low frequencies, the behavior is **mainly inductive**.

Influence of thermal reliefs at the frequency range of interest is very small to negligible when at least 2 legs are present.

# 1. R&D Activities

## Thermal relief

DC resistance



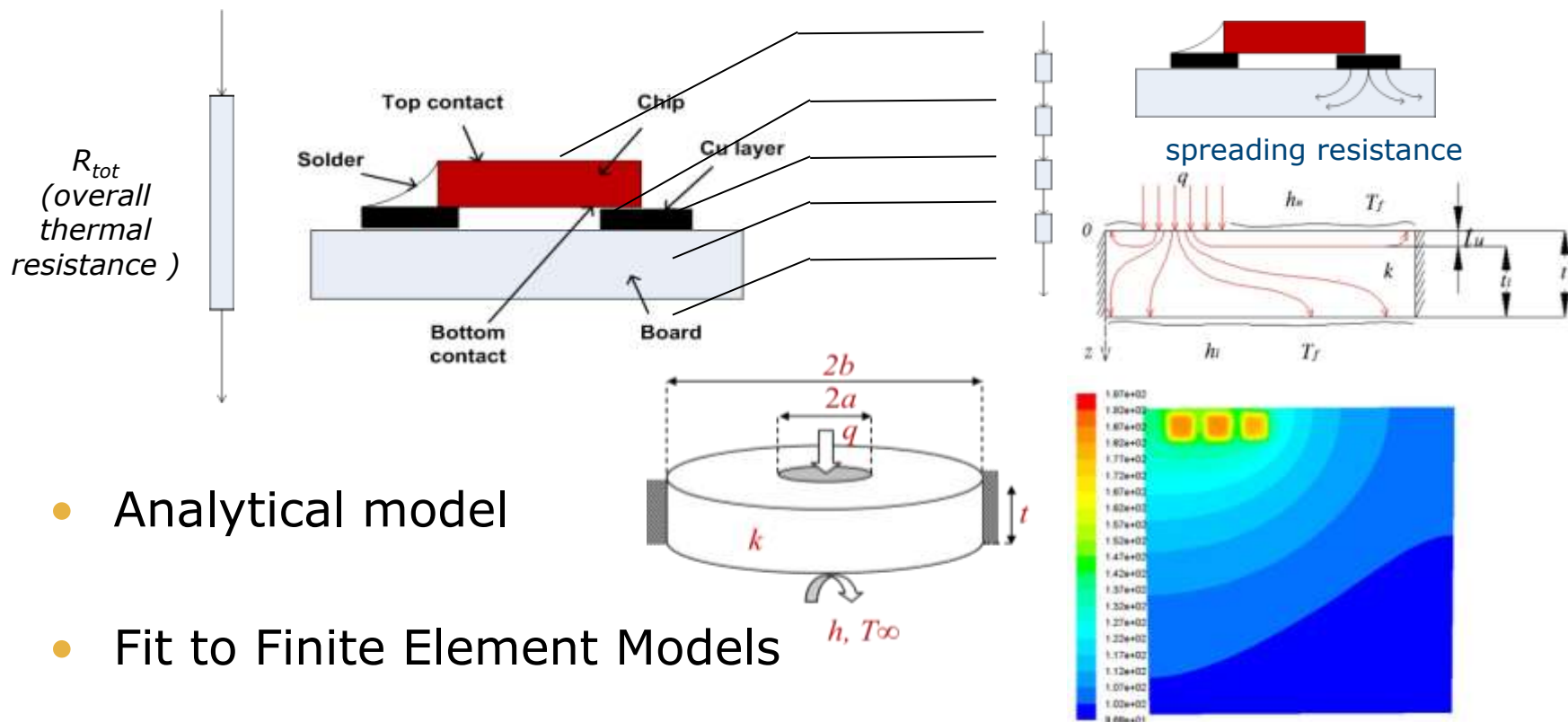
Description	R (mOhm)
No relief	0,752
4 traces	1,28
3 traces	1,53
2 traces	2,04
1 trace	3,64

The excess resistance introduced by the presence of a thermal relief lies in the range of **a milliohm to a few milliohms** (25 $\mu$ m Cu)

WIP: Self-heating, Effectiveness in wave solder hole filling

## Thermal design

Development of an analytical thermal resistance model at second level interconnect (similar to package level)



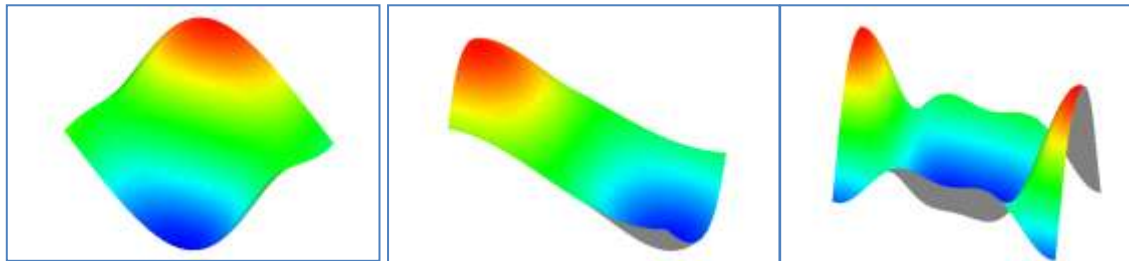
- Analytical model
- Fit to Finite Element Models

## Mechanical Design

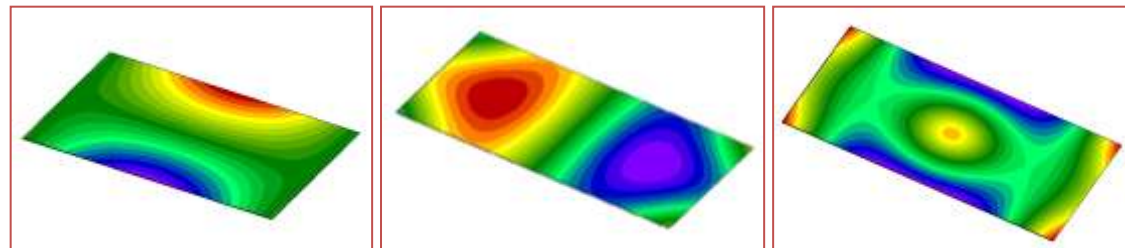
Where do we put fixations points in the PCB?  
(Prior to prototyping!)

Analytical modeling of PBA vibration response.

❖ Tool results



❖ Calculix results



Mode 1

Mode 2

Mode3

EDM-I-001 Mechanical Integration guideline

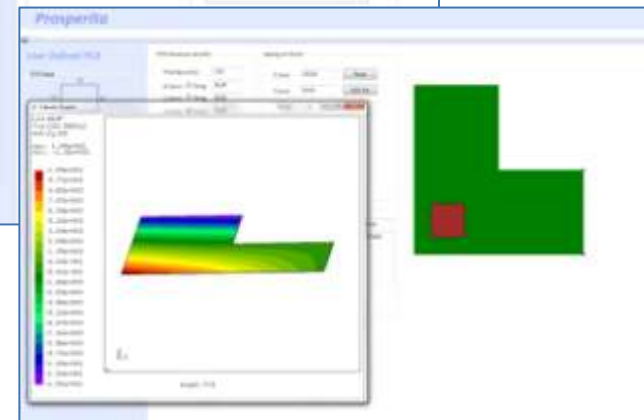
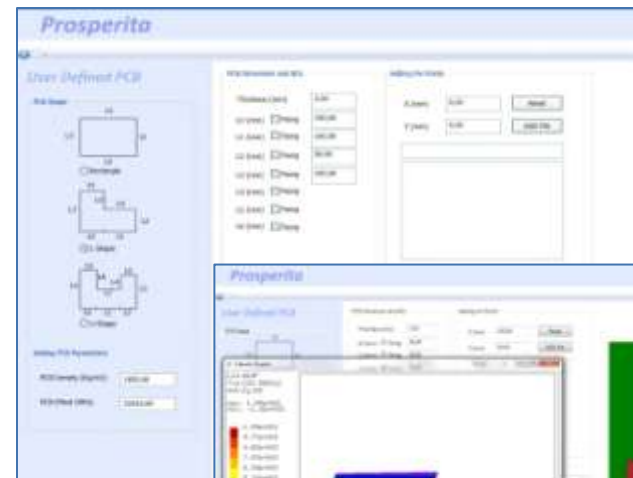
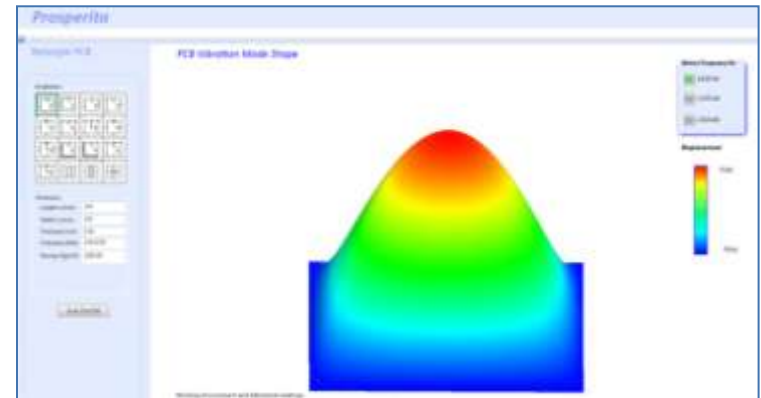


# 1. R&D Activities



## Vibration calculation tool

1. Tool for review at partners
2. Fast calculation of the eigenfrequency and the mode shape for rectangle PCB
3. Fast evaluation of the effects of heavy electrical components and fixing points for three PCB shapes.
4. Embedded preprocessor to generate mesh, set boundary conditions and run the open source FE software Calculix



# 1. R&D Activities

## Reliability

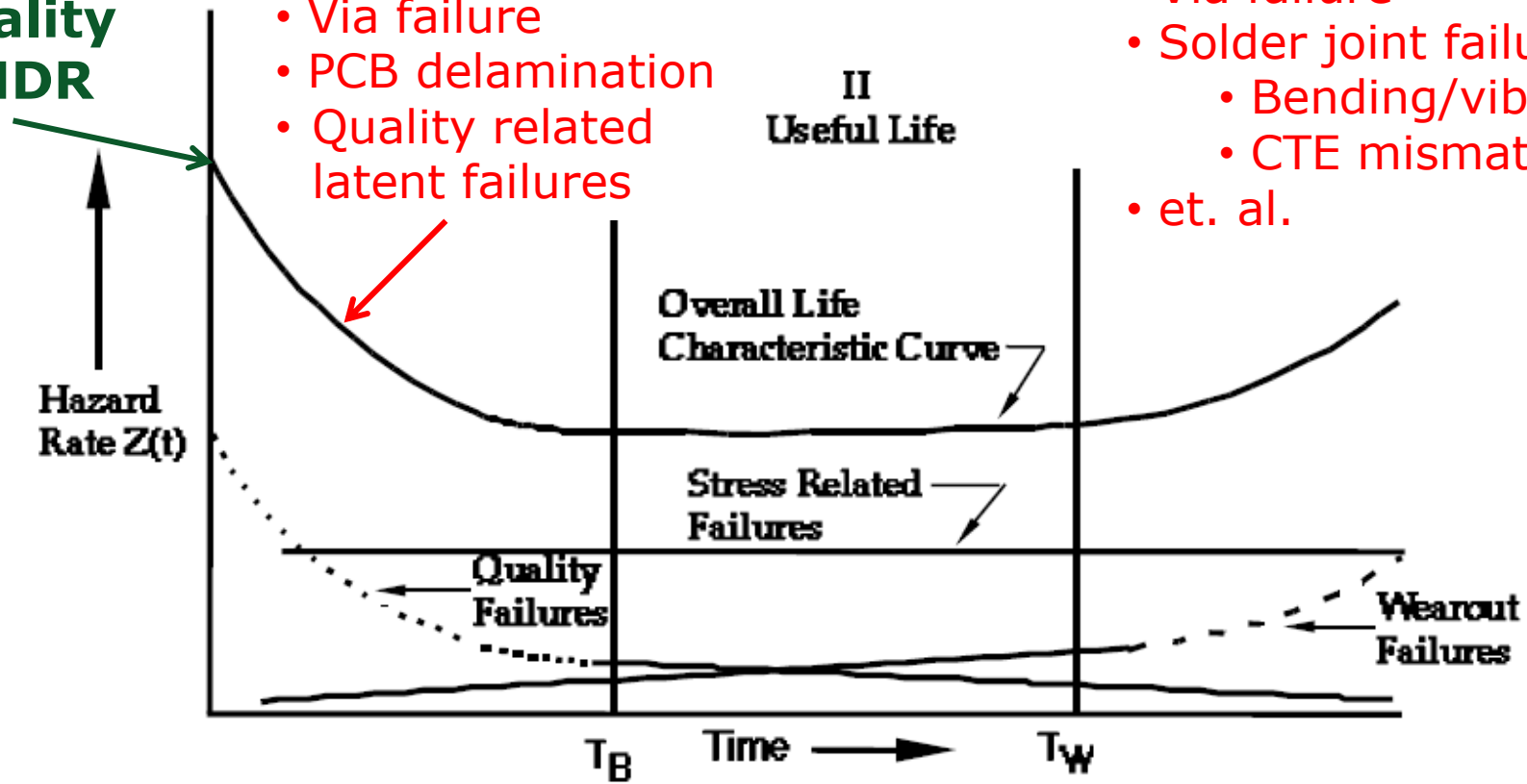
Quantified  
Quality  
ZHDR

### Early failure

- Via failure
- PCB delamination
- Quality related latent failures

### Reliability

- Via failure
- Solder joint failure
  - Bending/vibration
  - CTE mismatch
- et. al.

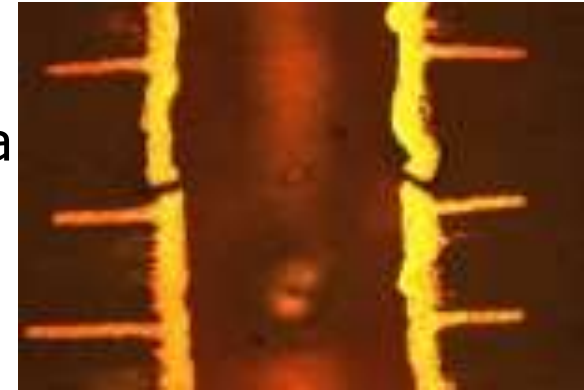




# 1. R&D Activities

## Via fatigue failure: basics

- Driving force: Difference in CTE between laminate and Cu-plating of via
- Via cracking observed for PTVs
- **Reliability prediction required**



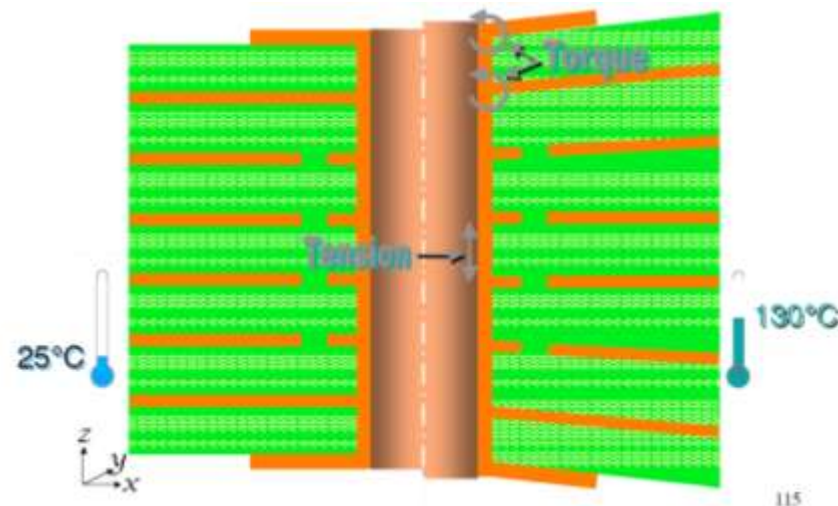
IPC-D-279 (1996)

*Design Guidelines for Reliable SMT PBA*

### 1-D analytical model (Engelmaier)

$$\Delta \varepsilon_2 = \frac{FE_E(\Delta T) - FE_{Cu}(\Delta T)}{1 + \frac{A_{Cu}}{A_E} \frac{E_{Cu}}{E_E}}$$

**Validity of expression for epoxy loading area  $A_E$ ?**



# 1. R&D Activities

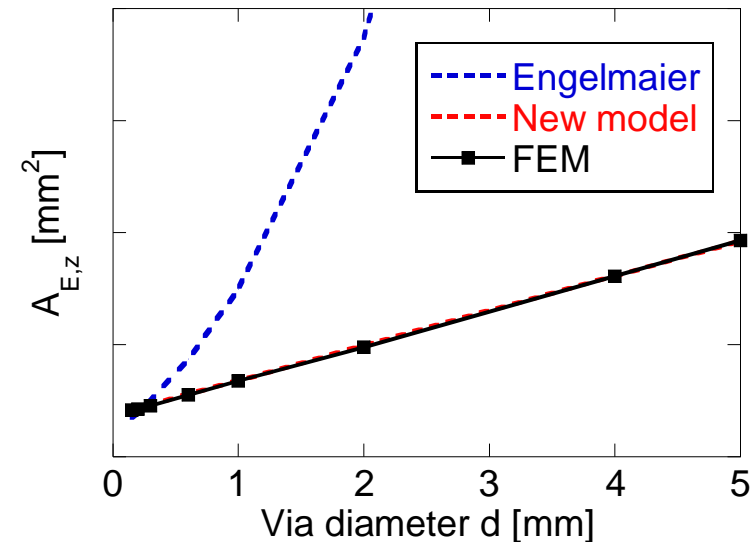
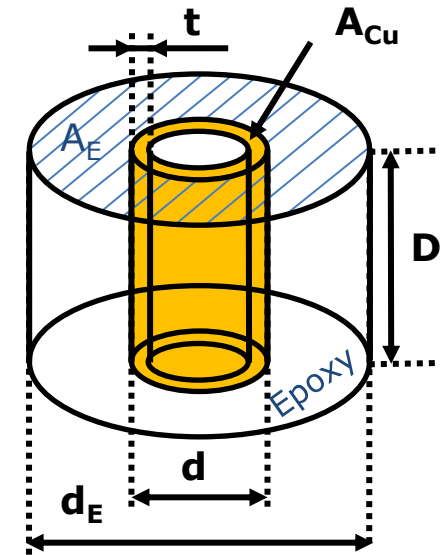
## Via strain model improvements by FEM

- Empirical relationship  
Engelmaier overestimates strain for large via diameter

$$A_E = \frac{\pi}{4} \left[ \frac{D^2}{4} + 4Dd + 3d^2 \right]$$

- New  $A_{E,z}$  model** developed depending on epoxy material parameters

$$A_{E,z} = b_1 D^2 + (a_1 E_{rt} + a_2) Dd$$



# 1. R&D Activities

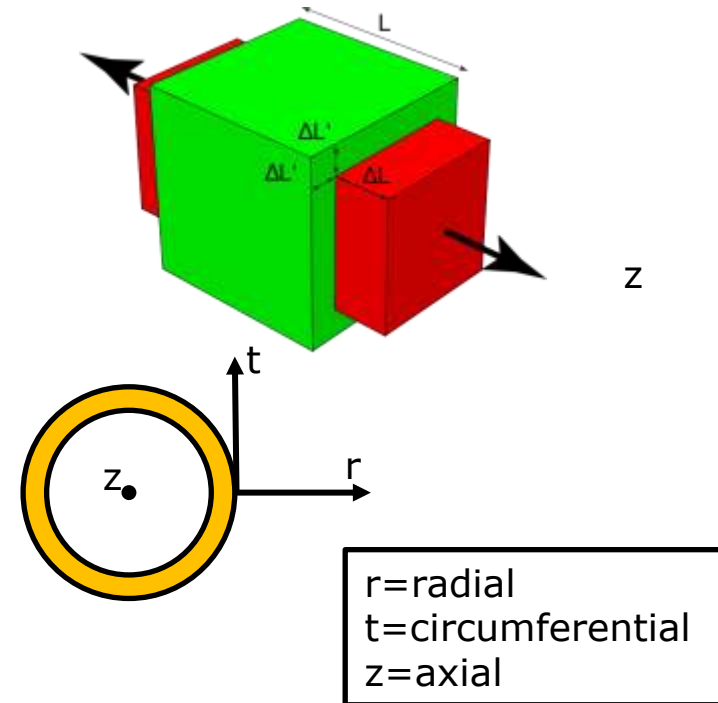
## Via strain model improvements by FEM (2)

- **Poisson effect copper**  $\nu_{Cu}$  causes reduction axial stress (z) due to in-plane (r,t) stresses
- 1D Engelmaier model extended to **axisymmetric model** taking into account **in-plane epoxy material parameters**
- **Epoxy influence zone**  $A_{E,t}$

$$\varepsilon_{Cu,z} = \frac{\Delta F E_z \left[ L + LM (1 - \nu_{Cu}^2) \right] - \Delta F E_{rt} \nu_{Cu} M}{1 + M + L + LM (1 - \nu_{Cu}^2)}$$

$$L = \frac{E_z}{E_{Cu}} \frac{A_{E,z}}{A_{Cu,z}}, M = \frac{E_{rt}}{E_{Cu}} \frac{A_{E,t}}{A_{Cu,t}}$$

$$A_{E,t} = (d + a_1 D)^2 \quad (\nu_{Cu} = 0: 1-D \text{ Engelmaier})$$

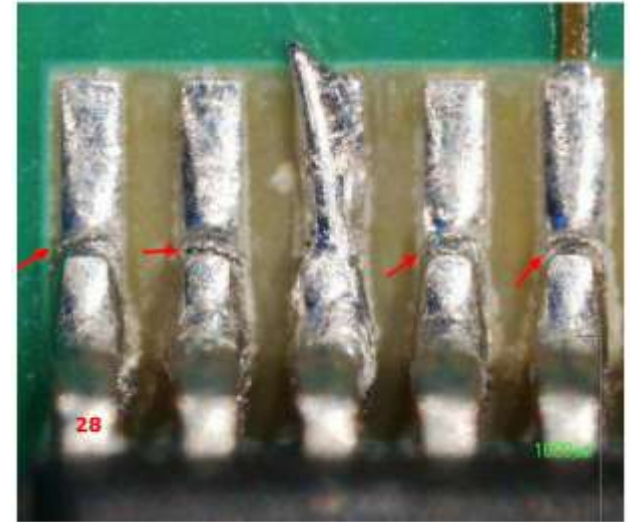


# 1. R&D Activities

## Solder joint reliability

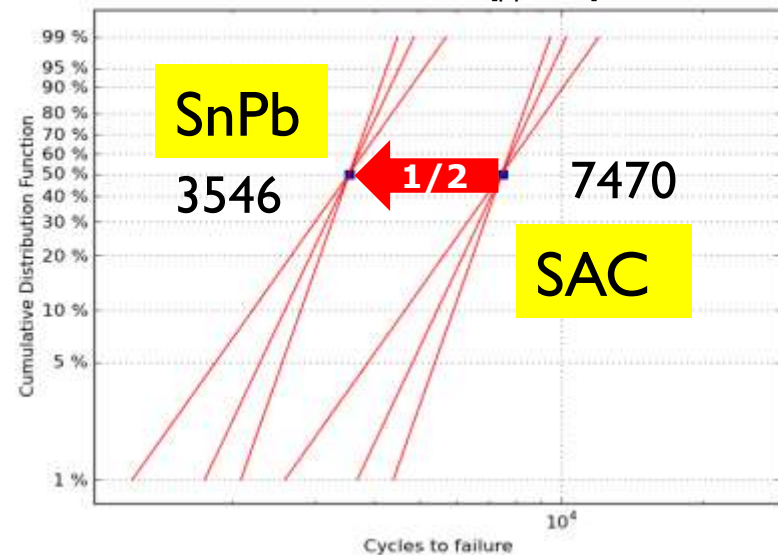
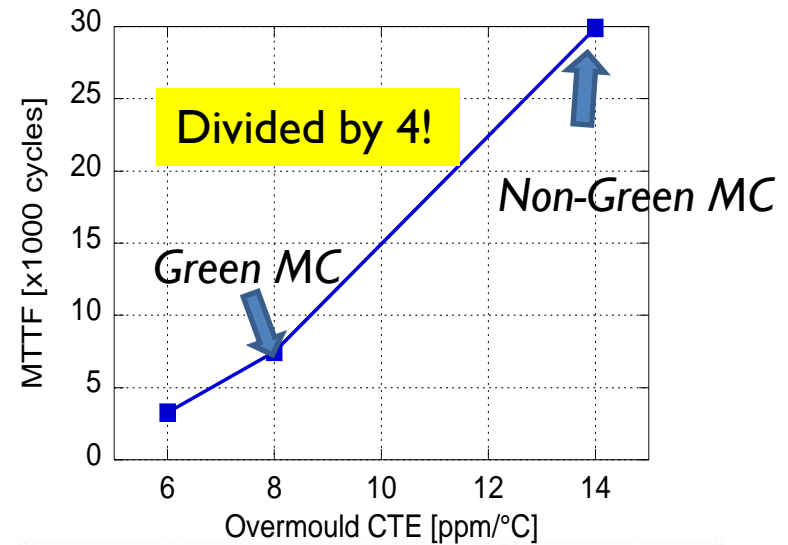
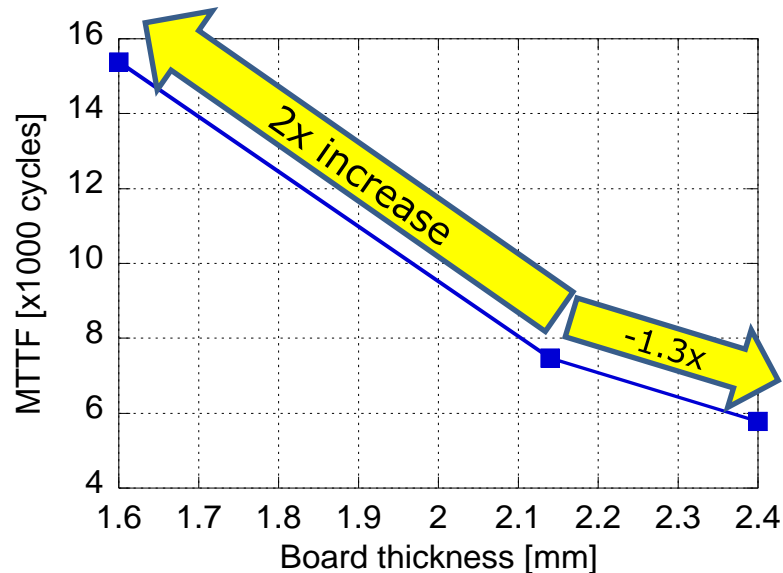
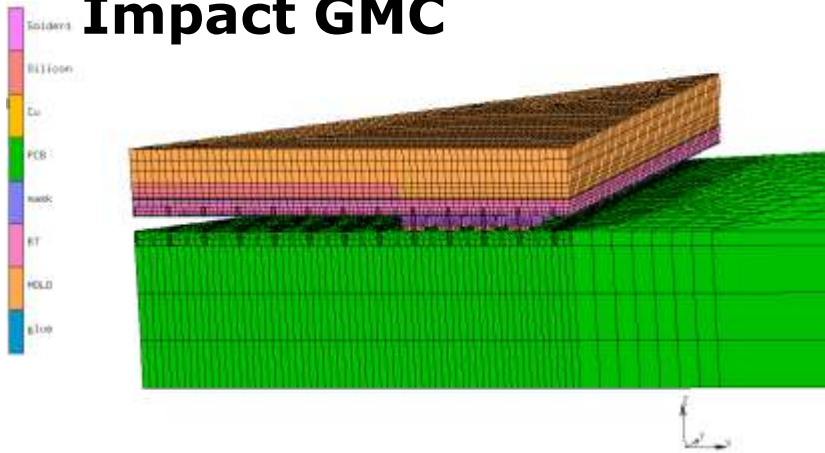
Need for analytical model to address:

- Low CTE “Green Mould Compound” packages
- Bending/vibration mechanical load
- IPC-D-279 model by Engelmaier
  - Leadless: Only shear loading of solder joints, no bending.
  - Leaded: only valid for elastically deformed solder joints
- New analytical model needs to address PCB and component bending correctly.
- Model concept defined. To be developed 2013.



# 1. R&D Activities

## Impact GMC



# 1. R&D Activities

## Research project participation



ENIAC-Greenelec

- Design-for-Recycling Guidelines
- Recyclability rating & tool
- Product data end-of-life availability



IWT-O&O: ISEE

- High reliability interconnection
- Solder and conductive adhesive
- Innovative accelerated testing
- Green Mould Compound testing
- Soldering to Cu vs. Ni (NiAu)
- Via reliability testing
- Accelerated vs. field testing



## 2. Guidelines

### PBA realization: DfM-DfR-DfT

Extra: D0: Good Design Practice

D1: PCB Specification V2

D2: Component Specification

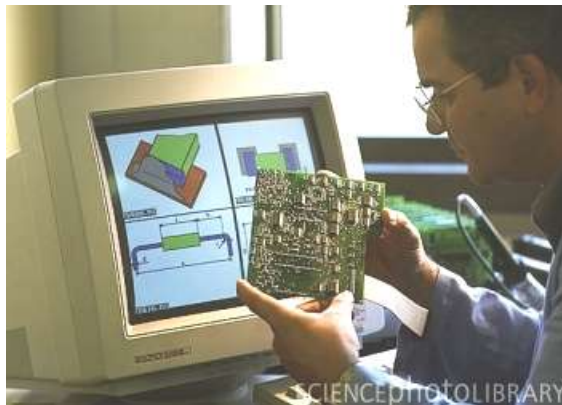
D3: Assembly material

D4: Design-for-Assembly

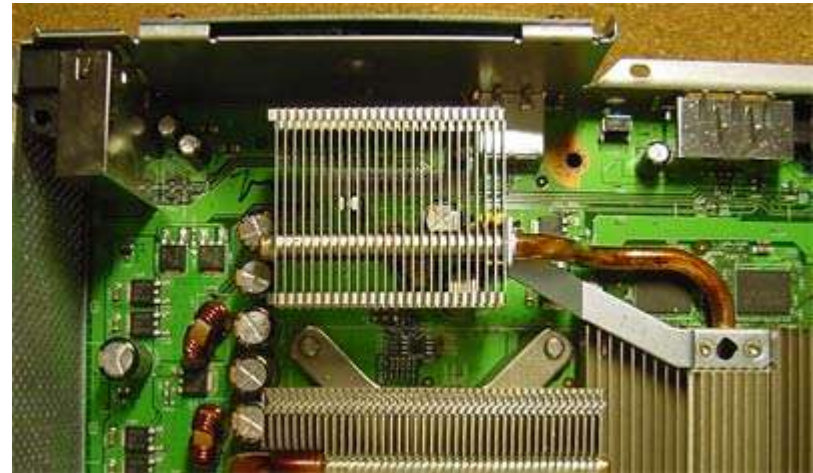
D5: PCB density classes

D6: PCB Layout

D7: Design-for-Test



VIS-traject PROSPERITA  
2011-2014



### PBA integration

I1: Mechanical interaction

I2: Thermal interaction

I3: EMC interaction

I4: integration



## 2. Guidelines

### EDM-D-000: Good Design Practice

Status: first draft available (addition to plan)

- Goal:

General Good DfX Practice – intro DfM guidelines

1. Applicable Documents
2. Applicability of the PBA DfM Guideline EDM-D-000
3. To acknowledge when designing PBA
4. Do's and don't's of good DfX practice
5. Basic Design-for-Assembly rules
6. Basic PCB Design-for-Manufacturing rules
7. Basic Design-for-Test rules
8. Basic Design-for-Reliability rules



## 2. Guidelines: EDM-D-001: PCB specification

Status: V2.0 – finalization

Major improvements

- Less descriptive, more directive, simpler to use
- Simplification of laminate selection w.r.t. via failure during soldering.
- Fundamentally renewed/improved analytical via model including:
  - Poisson effects in Cu barrel
  - FEM verified and modeled zone of influence in epoxy
  - Accurate full PCB/via dimension range analytical modeling
- Selection of via failure criteria options.
- Inclusion of IPC-1601 PCB moisture handling
- New approach/model for operational via lifetime determination.

## 2. Guidelines: EDM-D-003: Assembly materials

Status: Review

Goal: Provide Assembly Material specification guidelines

Content:

1. Applicable Documents
2. Applicability of the PBA DfM Guideline EDM-D-003
3. Solder alloy specification
4. Flux specification
5. Soldering paste specification
6. Cleaning of flux residues
7. Non-conductive Adhesives (SMD)
8. Coating, encapsulation, staking and repair polymers
9. Underfill
10. Conductive Adhesives and Films



## 2. Guidelines: EDM-D-004: Design-for-Assembly

Status: *started*

Goal: Provide DfA guideline: component placement

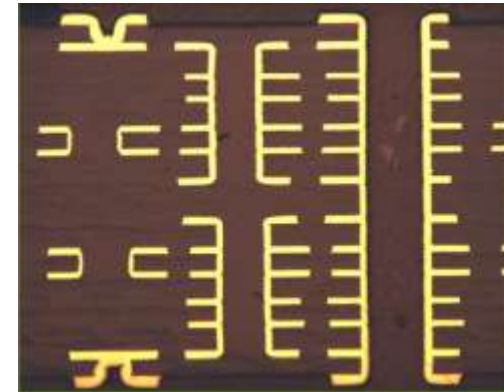
3. PBA performance requirements: general
4. PBA machine handling requirements
5. Selection of PBA type
6. Bill-of-Material (BoM) design
7. Placement: general
8. Placement and soldering: SMT reflow
9. Placement and soldering: THT wave
10. Placement and soldering: SMT wave
11. Placement and soldering: THT reflow
12. Placement and soldering: THT selective
13. Depanelization
14. PBA repair

## 2. Guidelines: EDM-D-005: PCB Build-up/Density class

Status: Released

Goal: PCB build-up and interconnection density selection

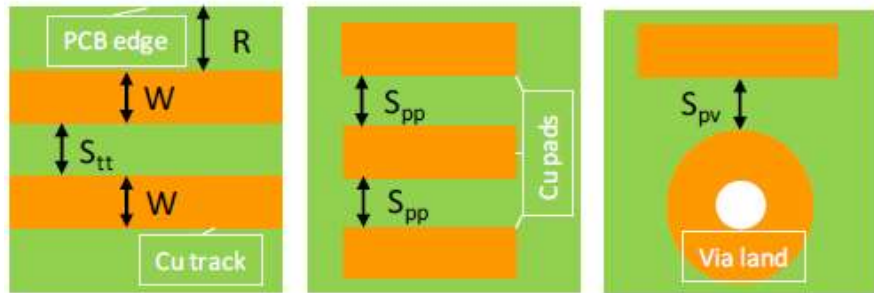
1. Applicable Documents
  2. Applicability of the PBA DfM Guideline EDM-D-005
  3. PCB Build-up
  4. PCB Density Classification
  5. PCB Build-Up nomenclature
  6. Guideline to PCB Density Classification application
- Appendix A: PCB Density Class vs. BGA break-out
- Appendix B: PCB capability inquiry



15<sup>th</sup> EDM Workshop, 23/11/2012, Barco, Kuurne.  
Will be distributed to participants.

## 2. Guidelines: EDM-D-005: PCB Build-up/Density class

### Track class

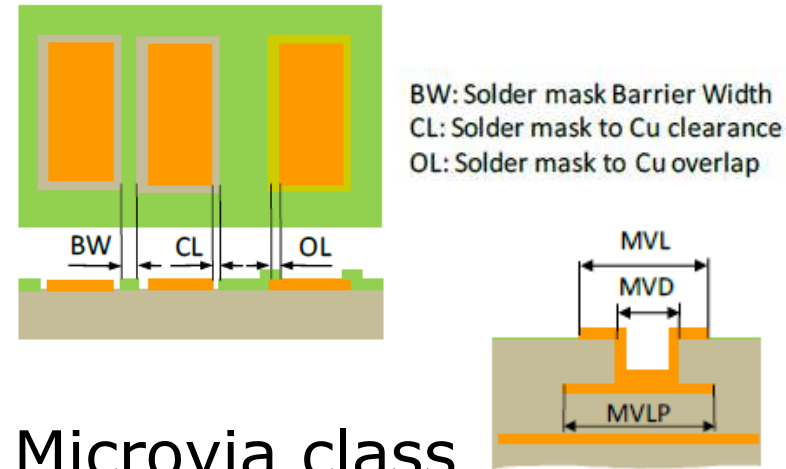


$W$ : Cu track width  
 $S_{tt}$ : Cu track spacing  
 $R$ : Routing distance

$S_{pp}$ : Pad-to-Pad spacing

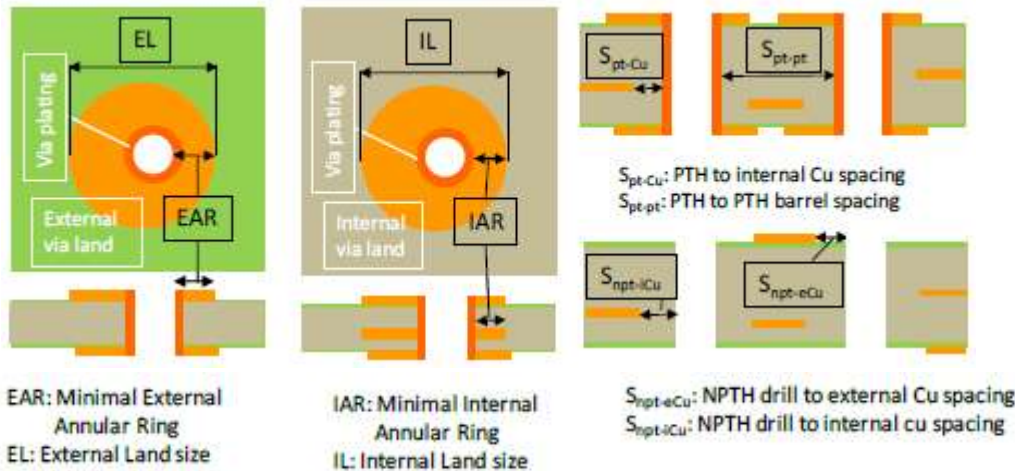
$S_{pv}$ : Pad-to-Via spacing

### Solder Mask class



$BW$ : Solder mask Barrier Width  
 $CL$ : Solder mask to Cu clearance  
 $OL$ : Solder mask to Cu overlap

### Via class

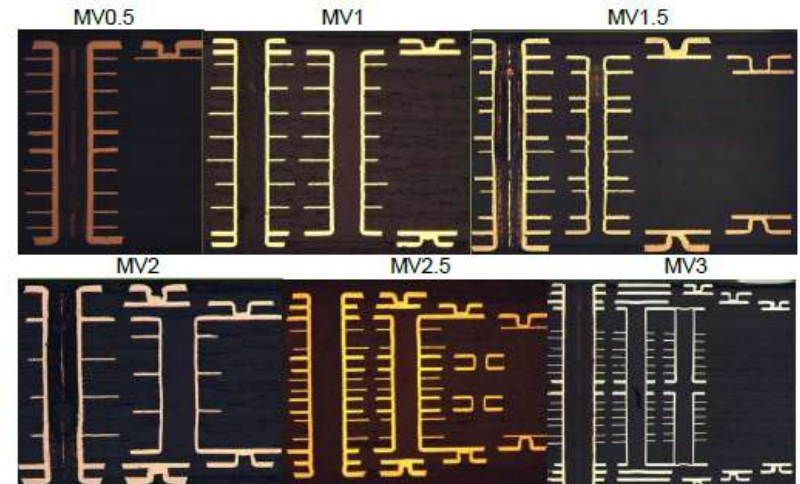


$EAR$ : Minimal External Annular Ring  
 $EL$ : External Land size

$IAR$ : Minimal Internal Annular Ring  
 $IL$ : Internal Land size

$S_{npt-eCu}$ : NPTH drill to external Cu spacing  
 $S_{npt-iCu}$ : NPTH drill to internal cu spacing

### Microvia class





## 2. Guidelines: EDM-D-005: PCB Build-up/Density class

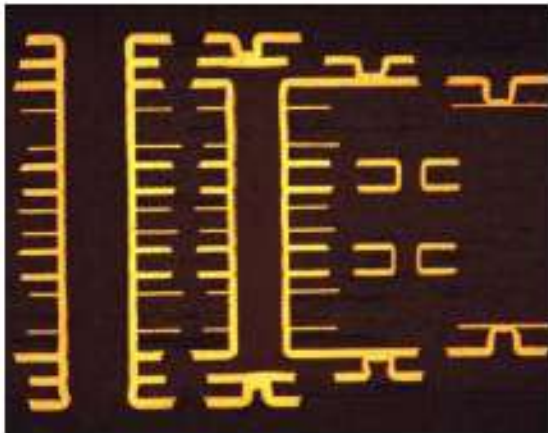
### Build-up nomenclature

**2-12-T125-V150 -{1.9-10-T100-V125-/121}-/121-MV1.5-SM60-b4**



A 2mm thick 12-layer PCB of track class T125 and via class V150 with /121 type laminate with 2 levels of micro-via of which one back-drilled in a 1.9mm thick 10-layer buried via core using T100/V125 density classes and /121 laminates. The PCB has SM60 solder mask and a NiAu finish.

**2.4-16-T100+-V125+-{2-12-T125-V125-{2x0.2-2-T125-V125-/101}-/101}-/101-MV2.5-SM50-b1**



A 2.4mm thick 16-layer PCB with track class T100 used on the external and the microvia build-up layers. It uses via class V125+ for the Z-direction interconnection of the top level PCB stack made of /101 type laminates. The PCB has one buried via 12 layer stack of 2mm thickness using T125/V125 track and via density classes. This core contains itself two 0.2 thick two layer buried via cores. All laminates are of type /101. The top level structure has two build-up levels of microvia and one level of back drilled microvia totaling three microvia levels. The PCB has a SM50 type solder mask and an immersion Ag finish.

## 2. Guidelines: EDM-I-001: Mechanical Integration

Status: first working draft

Goal: Determine fixation locations – Mechanical damage mitigation

1. Applicable Documents
2. Applicability of the PBA DfM Guideline
3. EDM-I-001 objective
4. Estimating the mechanical loading on the PBA
5. Mechanical failure mitigation: SMD
  - 5.1. Basic approach to SMD failure mitigation
  - 5.2. Extended approach to SMD failure mitigation
6. Mechanical failure mitigation: Through-hole
7. Mechanical failure mitigation: High profile SMD

## 2. Guidelines: EDM-I-001: Mechanical Integration

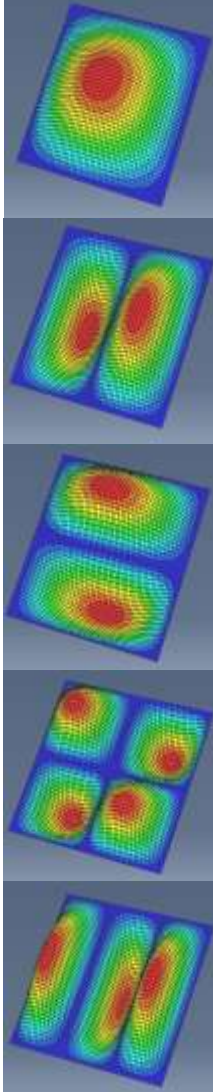
### Mechanical integration

#### Basic approach

- Determine eigenmodes and eigenfrequencies (tool)
- Place fixation points at antinodes of eigenmodes with eigenfrequencies within the loading spectrum.
- Verify.

#### Advanced approach

- Determine eigen modes, eigenfrequencies and amplitude.
- Eliminate eigenmodes with amplitudes exceeding limiting bending radius minimum.
- Verify.





# 3. Industry support

## Focus:

Transferring and implementing science based knowledge and methods to local industry.

- Production and operation failure root cause analysis and mitigation: How to avoid?
- Introduction of new technologies (for the company):
  - PCB technology
  - Component technology: packages
  - Assembly technologies
- Design-for-Reliability
- New Product Introduction and industrialisation

### 3. Industry support

#### Root cause analysis & how to avoid

Solder joint failures	Contamination	PCB failures	Displays
Component failures	Assembly quality	LED failures	...

#### Product- & Process Innovation

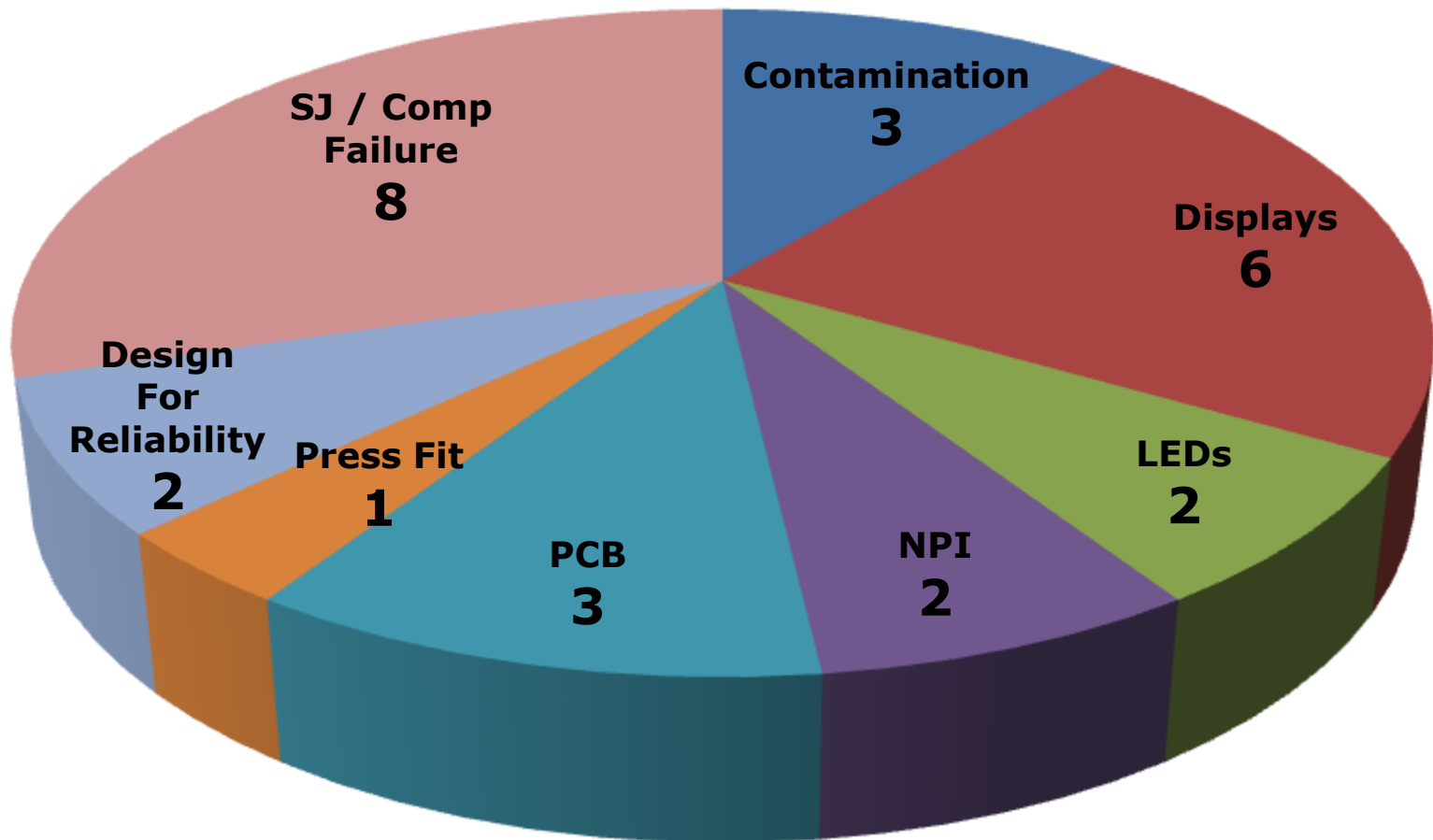
NPI Methodology	PCB/PBA Specification	New assembly processes	Lead free
Component aspects	Design rules	Product / Process / Supplier qualification	...

#### Training

Basic PBA Training	Advanced PBA Training	PCB/PBA Technology seminars
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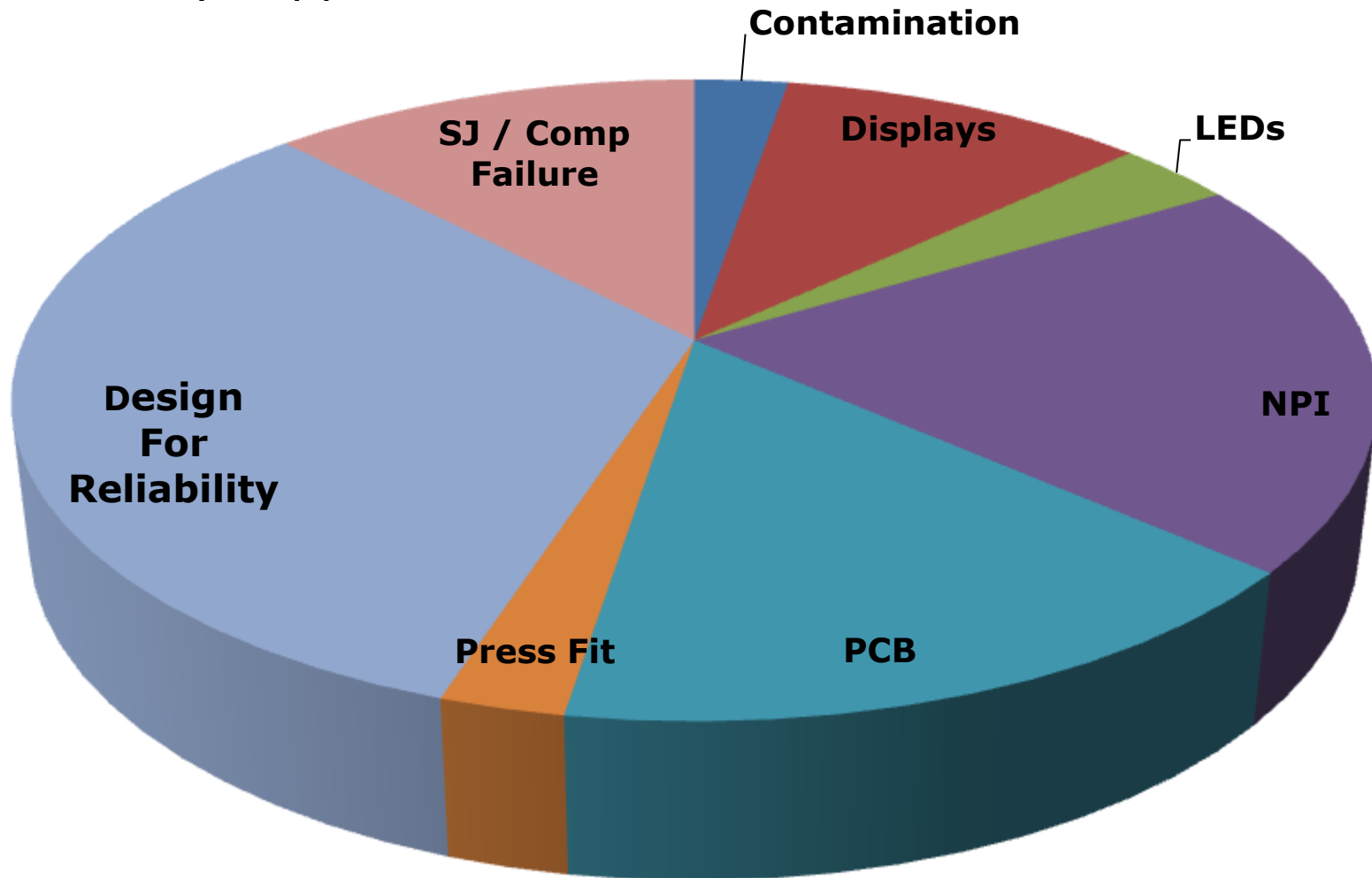
### 3. Industry support

Most requested consultancy subjects 2012 (27 projects)



### 3. Industry support

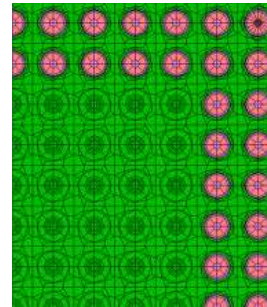
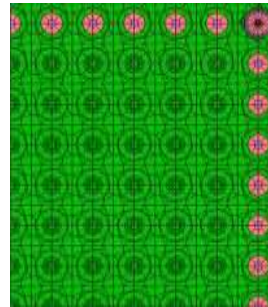
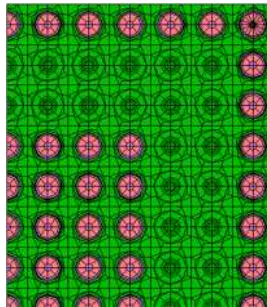
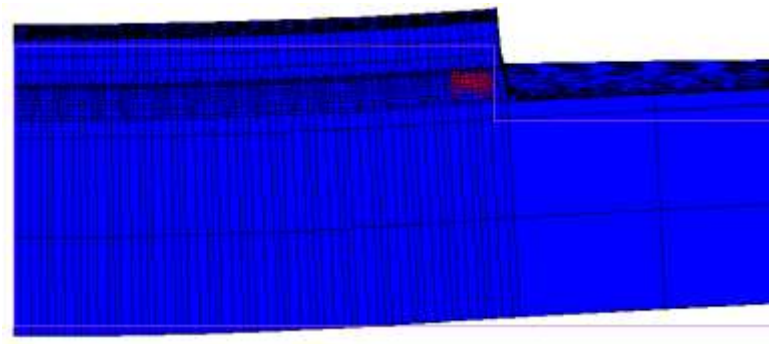
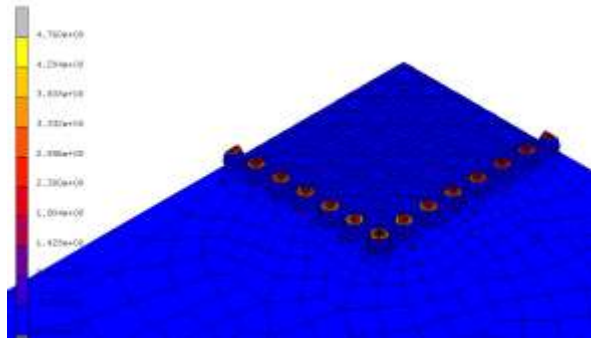
Industry support 2012: effort



# 3. Industry support: main topics 2012

## Design-for-Reliability

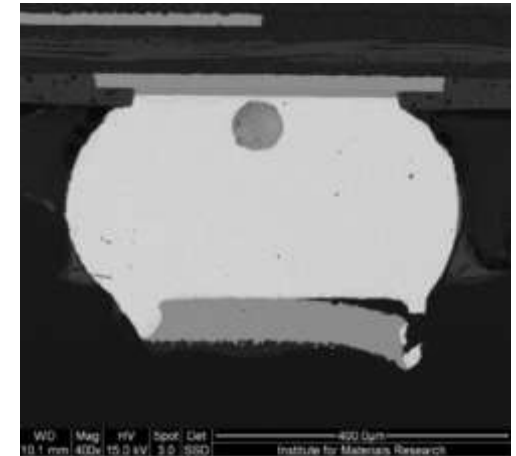
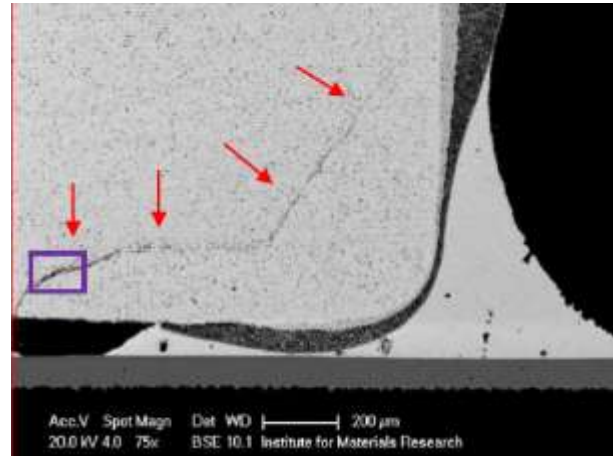
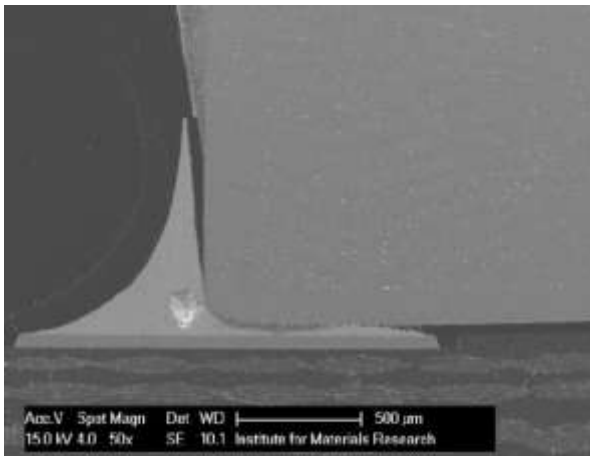
- Goal: Design optimisation for lifetime and cost
- Simulate impact of design parameters (package)
- Predict lifetime



# Service projects: main topics 2012

## Solderjoint failure / Component failure

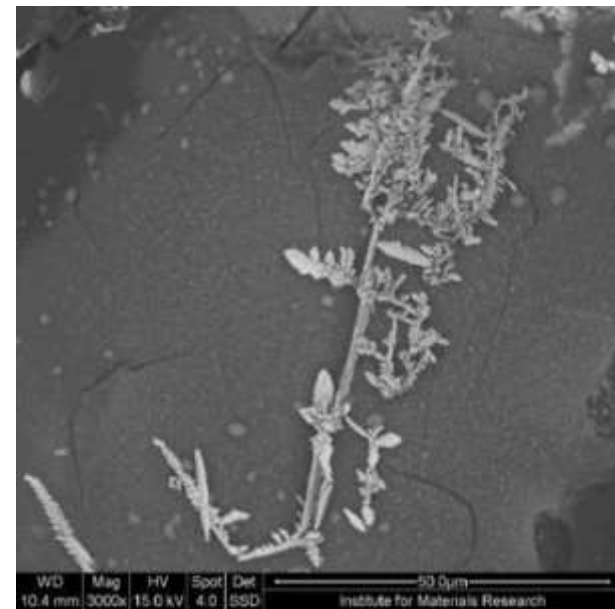
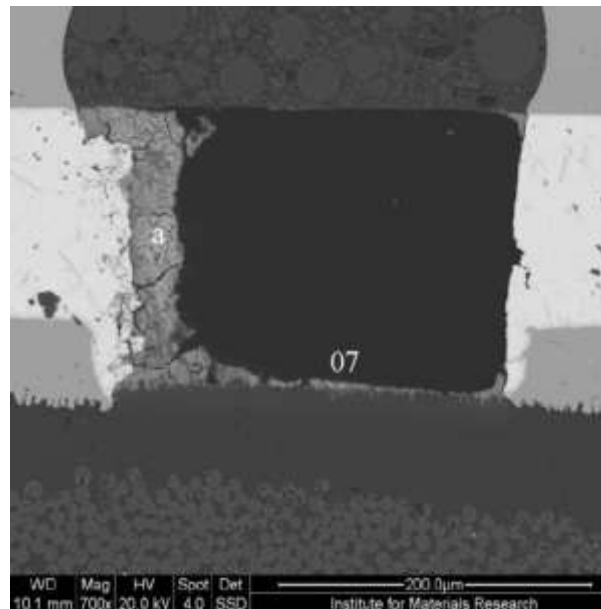
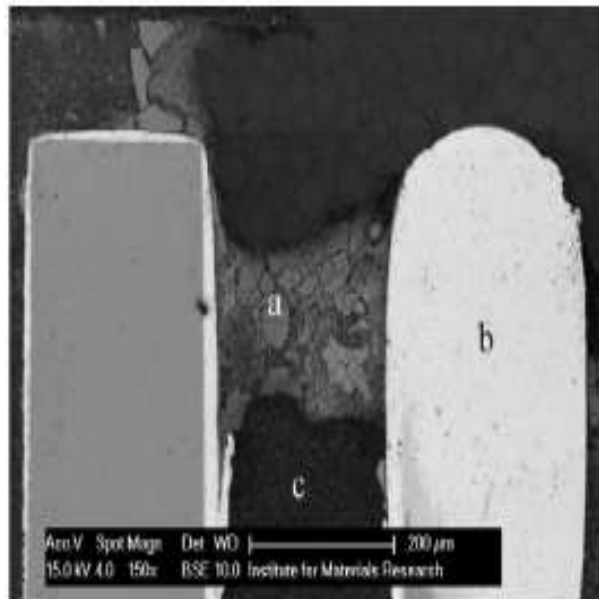
- Identify failures: solder joint, lead, PCB, component,...
- Solder joint quality
- Component quality
- Determine root cause and how to prevent
- Impact of design and component specification



# 3. Industry support: main topics 2012

## Contamination and SIR

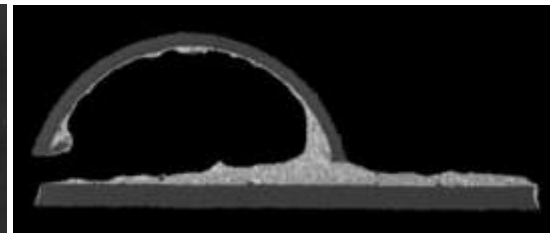
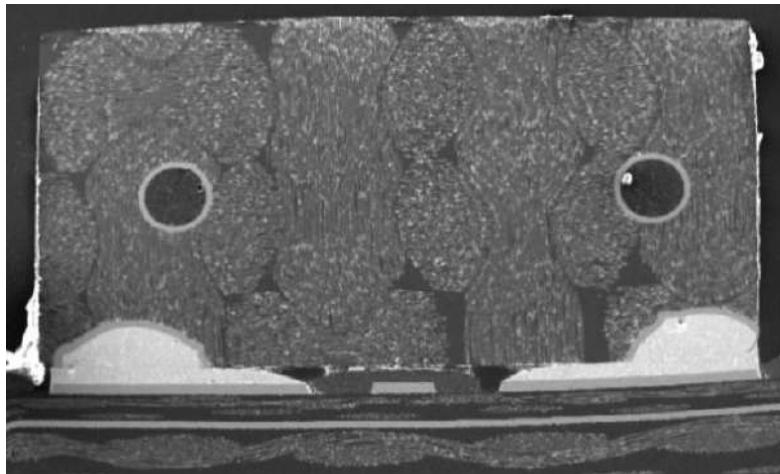
- Analysis of PCB or PBA contamination
  - PCB: poor cleaning (HASL flux, finish chemistry)
  - Assembly materials: poor cleaning (eg. flux)
  - Environment
- Determine root cause and how to prevent



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#### LEDs

- Solderjoint analysis of odd-shaped leds
- Assembly improvements for led assembly

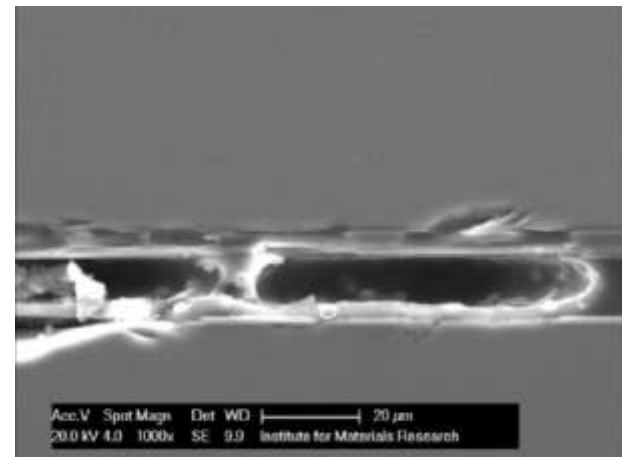
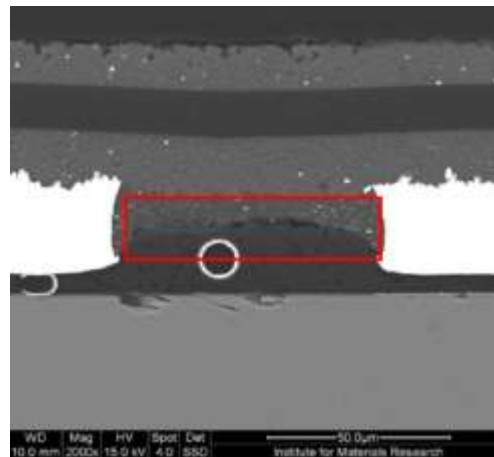
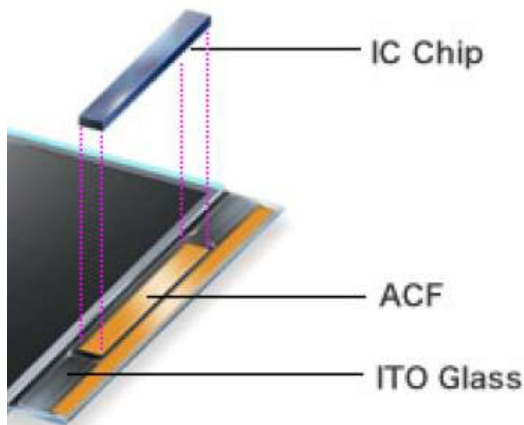




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## Displays

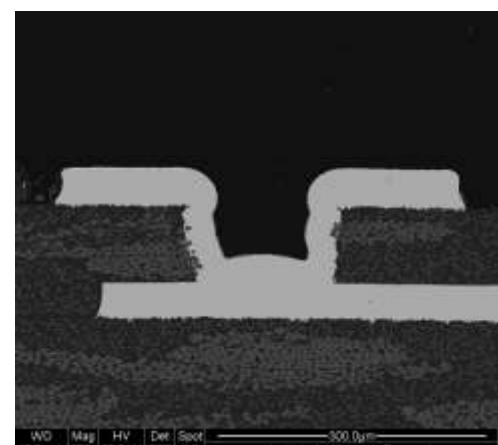
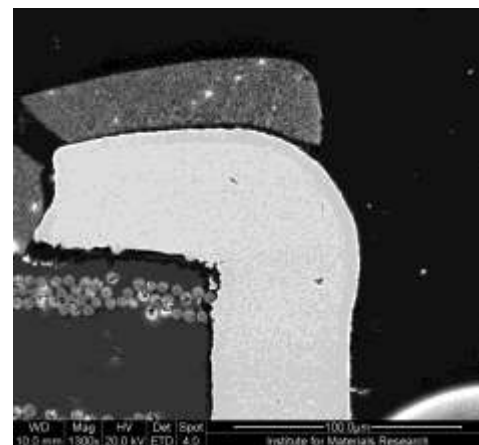
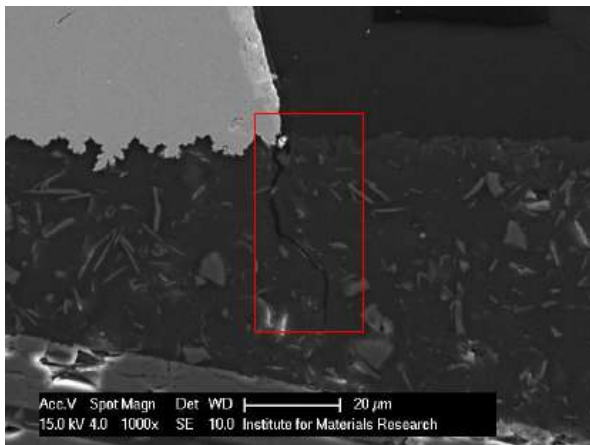
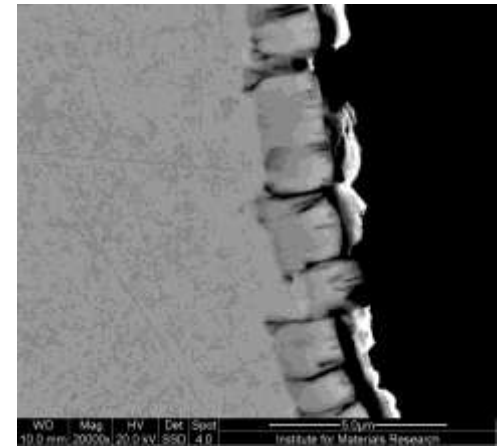
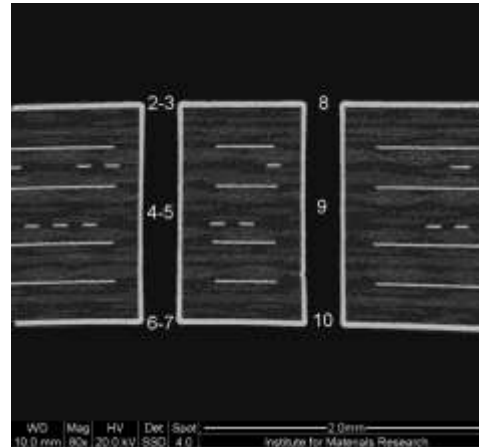
- Chip On Glass (COG)/Foil On Glass (FOG) technology
- How to test?
- Delamination and voiding
- Design, material and process improvement



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## PCB

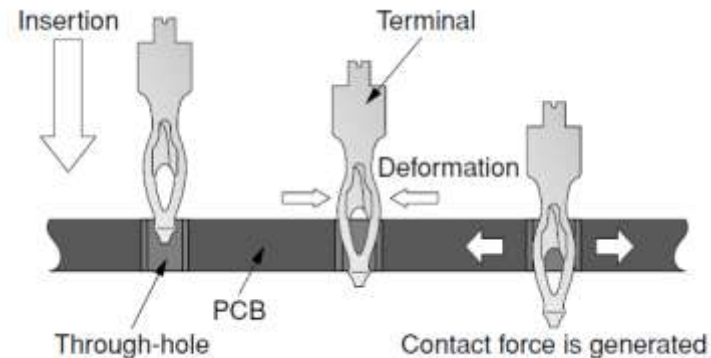
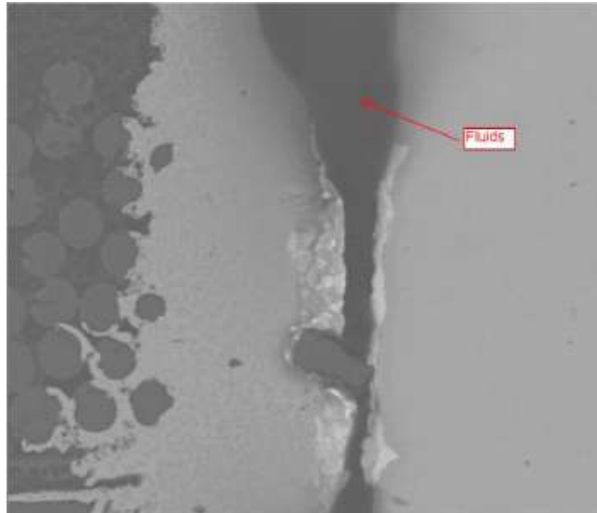
- Analysis of PCB failure
  - Via cracking
  - Delamination
  - Pad cratering
  - SIR
- How to qualify PCB?



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## Press Fit

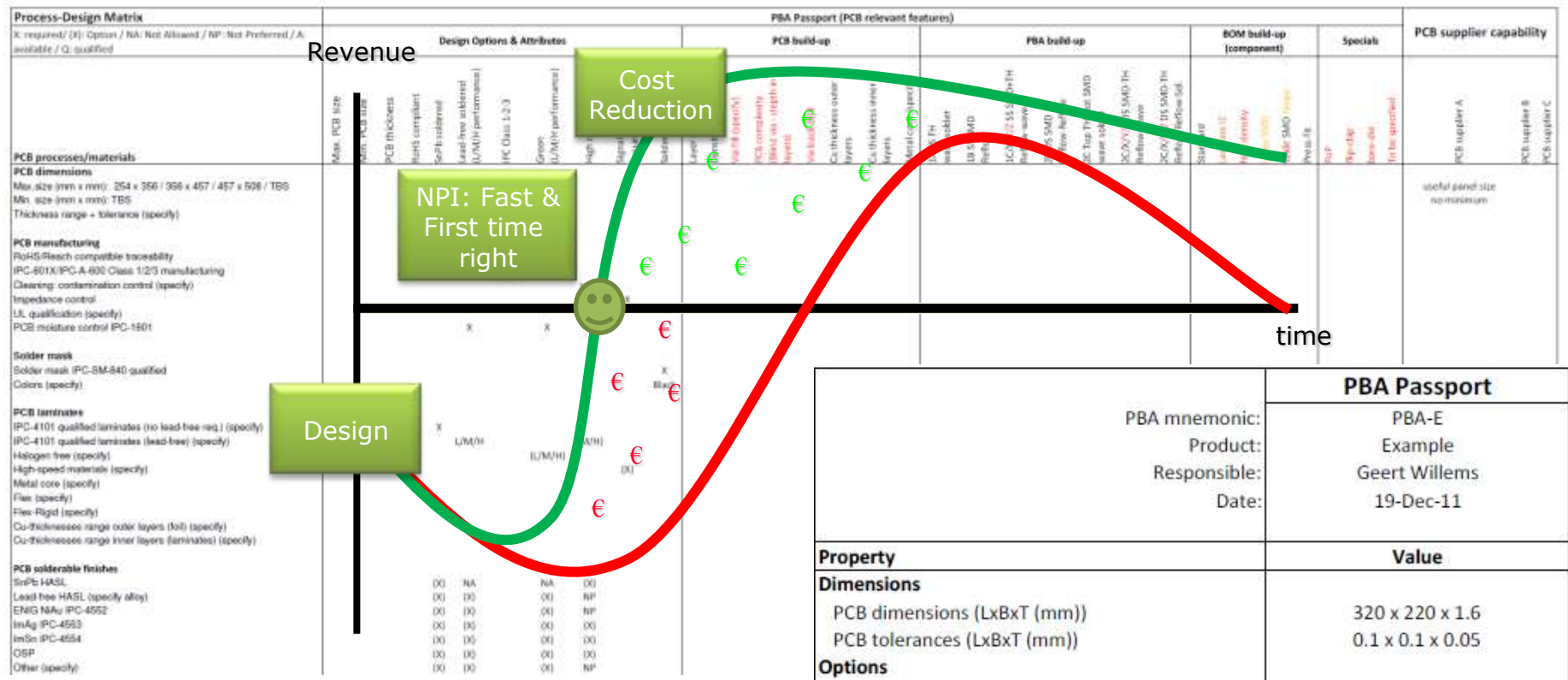
- Detect contact problems and find root cause
  - Design related
  - Fretting corrosion
  - Component quality
  - ...



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## New Product Introduction

- NPI Methodology setup, benchmark or advice
- Mapping design versus PCB & PBA supplier capability





# Thank you



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